

FDB28N30 N-Channel UniFETTM MOSFET 300 V, 28 A, 129 mΩ

Features

- $R_{DS(on)}$ = 108 m Ω (Typ.) @ V_{GS} = 10 V, I_D = 14 A
- Low Gate Charge (Typ. 39 nC)
- Low C_{rss} (Typ. 35 pF)
- 100% Avalanche Tested
- RoHS Compliant

Applications

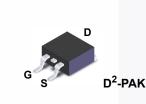
- Uninterruptible Power Supply
- AC-DC Power Supply

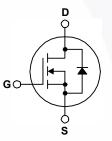
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Description

UniFETTM MOSFET is Fairchild Semiconductor's high voltage MOSFET family based on planar stripe and DMOS technology. This MOSFET is tailored to reduce on-state resistance, and to provide better switching performance and higher avalanche energy strength. This device family is suitable for switching power converter applications such as power factor correction (PFC), flat panel display (FPD) TV power, ATX and electronic lamp ballasts.





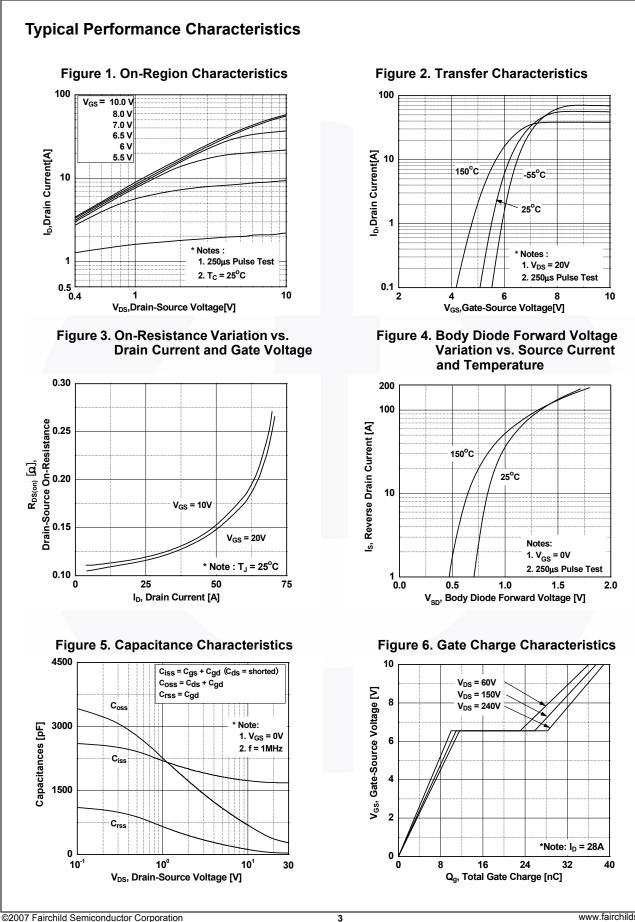
MOSFET Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol	Parameter		FDB28N30	Unit		
V _{DSS}	Drain to Source Voltage			300	V	
V _{GSS}	Gate to Source Voltage			±30	V	
	Drain Current	- Continuous (T _C = 25 ^o C)		28		
I _D	DrainCurrent	- Continuous (T _C = 100 ^o C)		19	- A	
I _{DM}	Drain Current	- Pulsed	(Note 1)	112	А	
E _{AS}	Single Pulsed Avalanche Energy (Note 2)			588	mJ	
I _{AR}	Avalanche Current (Note 1)			28	А	
E _{AR}	Repetitive Avalanche Energy (Note 1)			25	mJ	
dv/dt	Peak Diode Recovery dv/dt (Note 3)		(Note 3)	4.5	V/ns	
P _D	Dewes Dissignation	$(T_{\rm C} = 25^{\rm o}{\rm C})$		250	W	
	Power Dissipation	- Derate above 25°C		2.0	W/ºC	
T _J , T _{STG}	Operating and Storage Temperature Range			-55 to +150	°C	
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds		nds	300	°C	

Thermal Characteristics

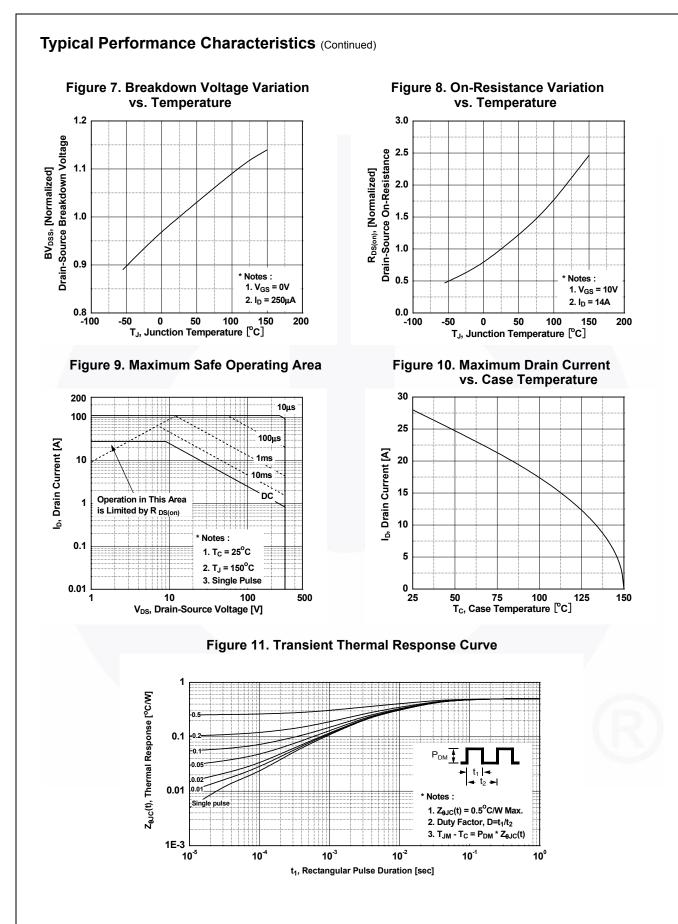
Symbol	Parameter	FDB28N30	Unit
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction to Case, Max.	0.5	
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction to Ambient (1 in ² Pad of 2-oz Copper), Max.	40	°C/W
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction to Ambient (Minimum Pad of 2-oz Copper), Max.	62.5	Ĩ

Part Number Top Mark		Top Mark	Package	Package Packing Method Reel Siz		e Ta	ape Width	Qua	antity
		D ² -PAK					800 units		
Electrica	l Chara	cteristics T _C = 25°C	unless othe	erwise noted.					
Symbol		Parameter		Test Condition	s	Min.	Тур.	Max.	Unit
Off Charad	cteristics								
BV _{DSS}		Source Breakdown Voltage	lo =	250 μA, V _{GS} = 0 V, T	, = 25°C	300	-	_	V
ΔBV _{DSS}	Drain to Source Breakdown Voltage Breakdown Voltage Temperature					000			
$/\Delta T_{J}$	Coefficier	v ,	I _D =	$I_D = 250 \ \mu A$, Referenced to $25^{\circ}C$			0.4	-	V/ºC
1	Zoro Cat	Zero Gate Voltage Drain Current		$V_{DS} = 300 V, V_{GS} = 0 V$ $V_{DS} = 240 V, T_C = 125^{\circ}C$		-	-	1	
I _{DSS} Zero Gate		s voltage Drain Current	V _{DS}			-	-	10	μA
I _{GSS}	Gate to B	ody Leakage Current	V _{GS}	s = ±30 V, V _{DS} = 0 V		-	-	±100	nA
On Charac	cteristics								
V _{GS(th)}	Gate Thre	eshold Voltage	VGS	_S = V _{DS} , I _D = 250 μA		3.0	-	5.0	V
R _{DS(on)}		ain to Source On Resistance		$_{\rm S} = 10$ V, $I_{\rm D} = 14$ A		-	0.108	0.129	Ω
9 _{FS}	Forward ⁻	Transconductance		_s = 40 V, I _D = 14 A		-	24.8	-	S
Dynamic (Character	istics							
C _{iss}	Input Capacitance					-	1690	2250	pF
C _{oss}		apacitance	$V_{\rm DS} = 25 \rm V, V_{\rm GS} = 0 \rm V,$		_	-	305	405	p. pF
C _{rss}		Transfer Capacitance	f = ′	f = 1 MHz		-	35	50	pF
Q _g		e Charge at 10V	V	$V_{DS} = 240 \text{ V}, \text{ I}_{D} = 28 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note 4)			39	50	nC
Q _{gs}		ource Gate Charge	V_DS				12	-	nC
Q _{gd}		Prain "Miller" Charge	• 68			-	17	-	nC
Switching		•							1
-		Delay Time					35	80	
t _{d(on)}	Turn-On F		Vor	V_{DD} = 150 V, I _D = 28 A, V _{GS} = 10 V, R _G = 25 Ω (Note 4)		-	135	280	ns
t _r		Delay Time				-	79	168	ns ns
t _{d(off)} t _f	Turn-Off F					-	69	148	ns
					(Note 4)	-	00	140	113
		Characteristics	o Diado For	word Current				28	•
I _S	Maximum Continuous Drain to Source					-	-	112	A
ISM M	Maximum Pulsed Drain to Source Diode					-	-	1.4	A V
V _{SD}		Source Diode Forward Voltag		_{IS} = 0 V, I _{SD} = 28 A		-	- 279	1.4	
t _{rr}		Recovery Charge	V _{GS}	V _{GS} = 0 V, I _{SD} = 28 A, dI _F /dt = 100 A/μs		-	279	-	ns μC
Q _{rr}	Reveiser	Recovery Charge	Gif,	ut 1007740		-	2.1	-	μΟ



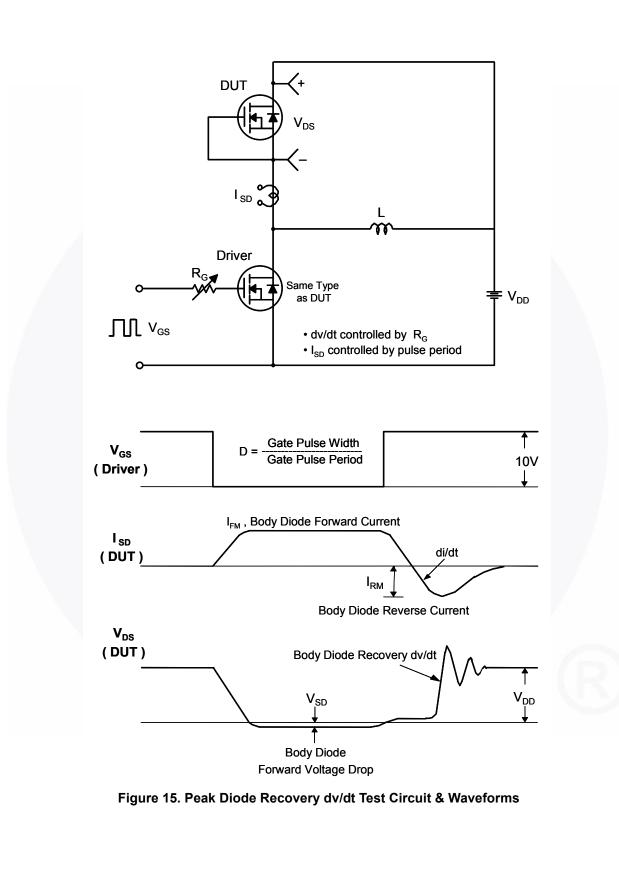
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 V_{GS} ξ א Q_g FV_{DS} Q_{gd} Q_{gs} • DUT I_G = const. Charge Figure 12. Gate Charge Test Circuit & Waveform R VDS V_{DS} 90% ο V_{DD} GS R_{G} 10% V_{GS} DUT V_{GS} ∏ 0 Figure 13. Resistive Switching Test Circuit & Waveforms L $E_{AS} = \frac{1}{2} L I_{AS}^2$ V_{DS} $\mathsf{BV}_{\mathsf{DSS}}$ ID o I_{AS} R_{G} ŧν_{DD} $I_{D}(t)$ V_{GS}] $V_{DS}(t)$ V_{DD} DUT Time t_p Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



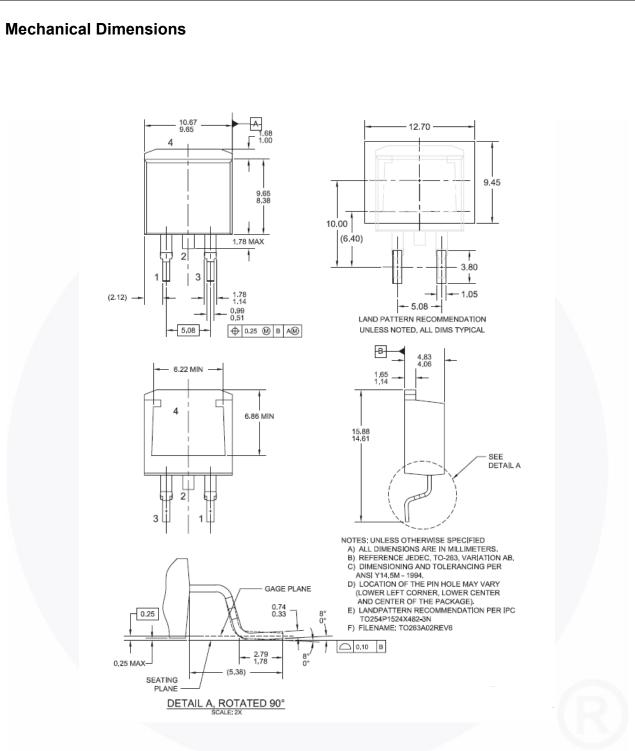


Figure 16. TO263 (D²PAK), Molded, 2-Lead, Surface Mount

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